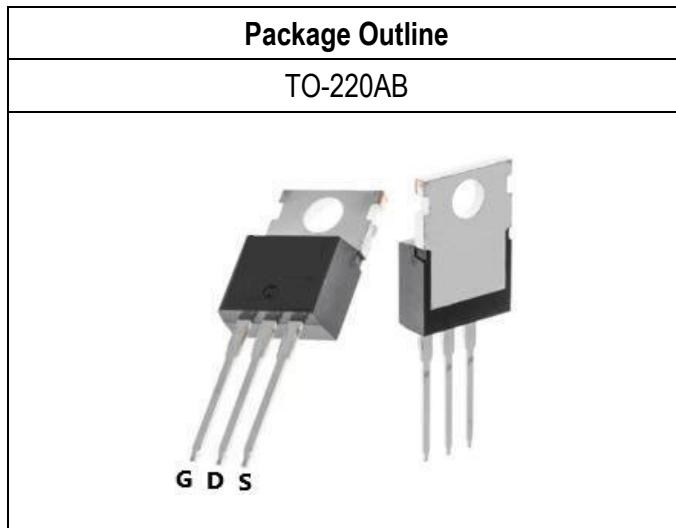


Key Electrical Characteristics		
Parameter / Symbol	Value / Description	Unit
BV_{DSS} min.	650	V
$R_{DS(on)}$ Typ. @10V	151	$m\Omega$
I_D	20.4	A
V_{TH} Typ.	3.0	V
C_{iss} Typ.	1754	pF
Q_g 10V	40.2	nC
ESD (HBM)	≥ 2	kV



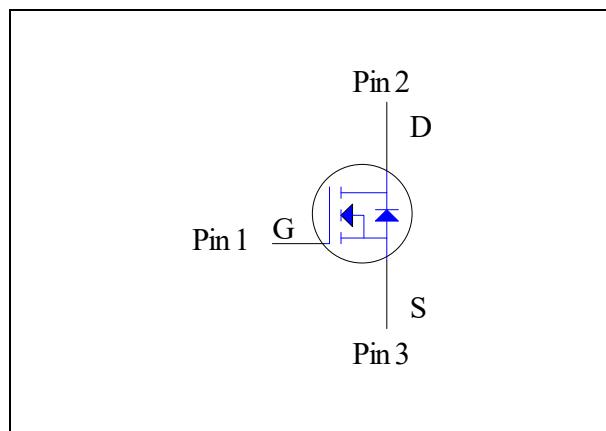
General Description

These devices are N-channel power MOSFET developed using Super Junction structure technology. There is high speed switching capacity, low $R_{DS(on)}$ parameter, excellent quality and characteristics for these devices. Moreover, it is a good choose in improved efficiency of circuit and raise power density are required. These features combine to be an advantage design for use in wide variety of application including switch mode power design.

Features

- ❖ Fast Switching
- ❖ Low $R_{DS(on)}$ resistance
- ❖ Low Switching Loss
- ❖ Improve ESD protection capabilities
- ❖ Stable thermal characteristics
- ❖ Excellent single pulse avalanche energy
- ❖ Pb-free Lead plating and RoHS compliant

Symbol and Pin assignment



Potential Applications

- ◆ AC to DC converter
- ◆ LED lighting power module
- ◆ Consumption electronics adaptor or charger
- ◆ Network equipment and display power supply unit
- ◆ Switch Mode Power Supply

Ordering Information

N.o	Item	Description
01	Orderable P/N	SJ650N180P2
02	Part Number	SJ650N180P2
03	Package Type	TO-220AB
04	Package Code	P
05	Packing Type	Tube
06	Quantity/pcs	50
07	RoHS Status	Halogen-Free

Content

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2.	Thermal Resistance Ratings -----	3
3.	Electrical Characteristics -----	4
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8.	Appendix -----	12-13

1. Absolute Maximum Ratings ($T_J=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Values			Unit
		Min.	Typ.	Max.	
Drain-Source Voltage	V_{DS}	-	-	650	V
Gate-Source Voltage	V_{GS}	-	-	± 30	V
Drain Current-Continuous ^{Note 1}	I_D	-	-	20.4	A
		-	-	12.9	A
Drain Current-Pulsed ^{Note 2}	I_{DM}	-	-	70	A
Avalanche Current	I_{AS}	-	-	5.7	A
Single Pulse Avalanche Energy ^{Note 3}	E_{AS}	-	-	129	mJ
Maximum Power Dissipation	P_D	-	-	189	W
		-	-	75.7	W
		-	-	1.51	W/ $^\circ\text{C}$
Body Diode dv/dt ^{Note 4}	dv/dt	-	-	14.4	V/nS
Max. Operating Junction Temperature	T_J	-	-	150	$^\circ\text{C}$
Storage Temperature Range	T_{STG}	-55	-	150	$^\circ\text{C}$

2. Thermal Resistance Ratings

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Thermal resistance, Junction-Case ^{Note 5}	$R_{\theta JC}$	Steady State	-	-	0.66	$^\circ\text{C/W}$
Thermal resistance, Junction-Ambient ^{Note 5}	$R_{\theta JA}$	Steady State	-	-	41.26	$^\circ\text{C/W}$

Notes:

1. Limited by silicon chip capability and $R_{\theta JC}$ junction-to-case thermal resistance.
2. Must be ensure junction temperature does not exceed 150-degree C. (Pulse Width $\leq 380\mu\text{s}$, Duty $\leq 2\%$)
3. Limited by T_{Jmax} , starting $T_J=25^\circ\text{C}$, $L=8\text{ mH}$, $R_g=25\Omega$, $I_{AS}=5.7\text{A}$, $V_{GS}=10\text{V}$.
4. $V_{DD} = 0\text{~}400\text{ V}$, $I_{SD}=I_S \leq 10\text{ A}$ starting $T_c = 25^\circ\text{C}$
5. The value of thermal resistance is measured with the single device put on cooling plate under a still air environment temperature is 25 degree C based on JEDEC standard JESD51-14 and JESD51-2a. Thermal resistance obtained depends on the user's specific board design and given application.
6. $C_{O(er)}$ is fixed capacitance that gives same stored energy as C_{oss} while V_{DS} rising to 400V from 0V.
7. $C_{O(tr)}$ is fixed capacitance that gives same charging time as C_{oss} while V_{DS} rising to 400V from 0V.

3. Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

STATIC CHARACTERISTICS						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{DS}}=250\mu\text{A}$	650	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}}=650\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	μA
		$V_{\text{DS}}=650\text{V}, V_{\text{GS}}=0\text{V}, T_J=125^\circ\text{C}$	-	-	10	μA
Gate-Body Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 30\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA

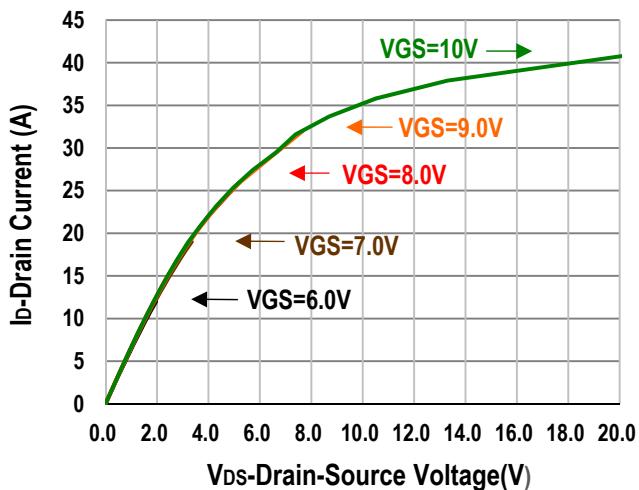
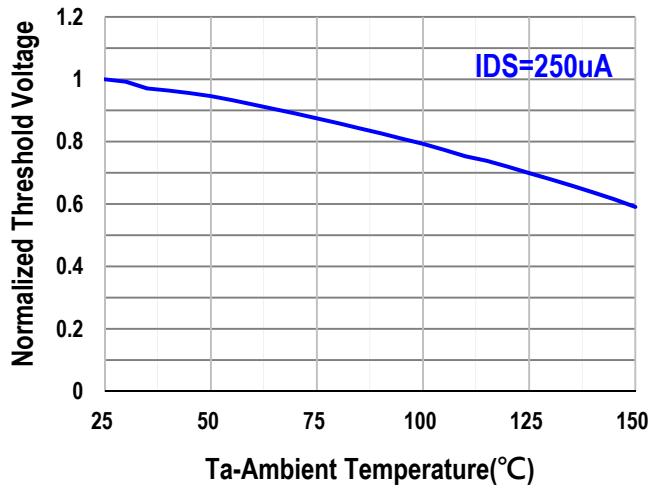
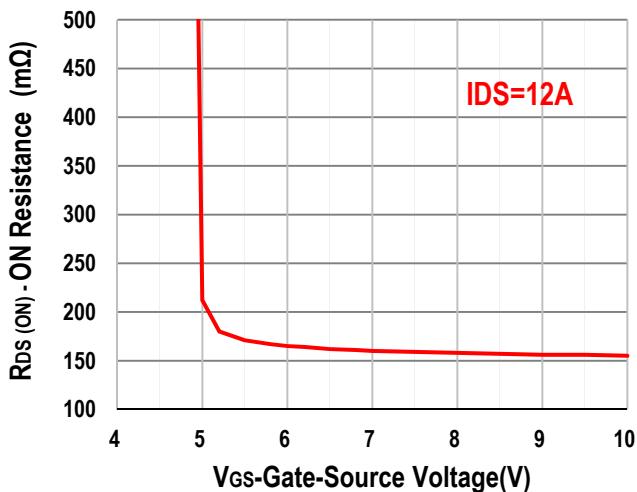
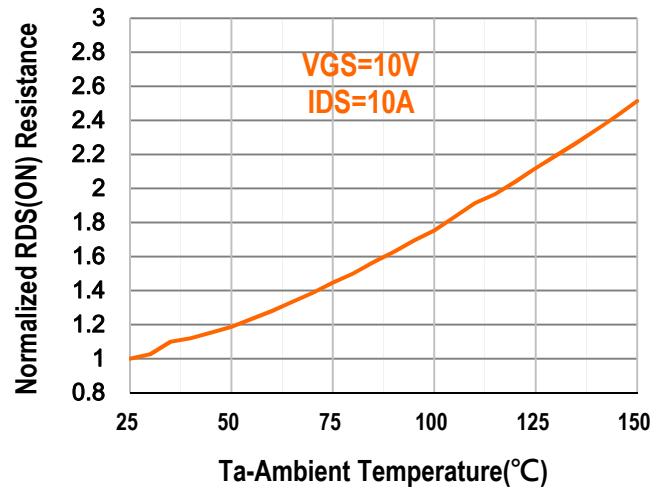
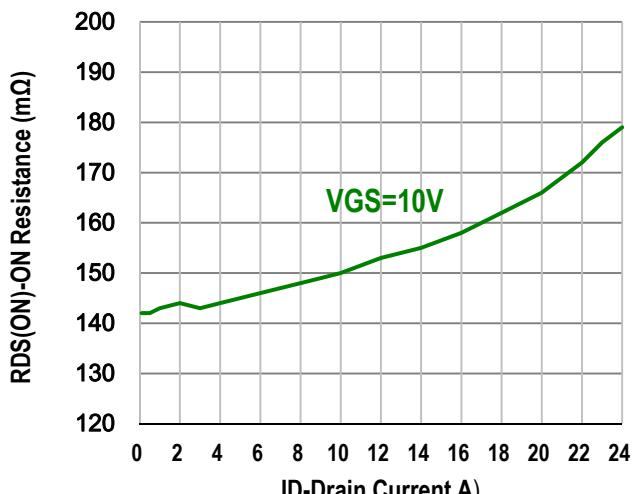
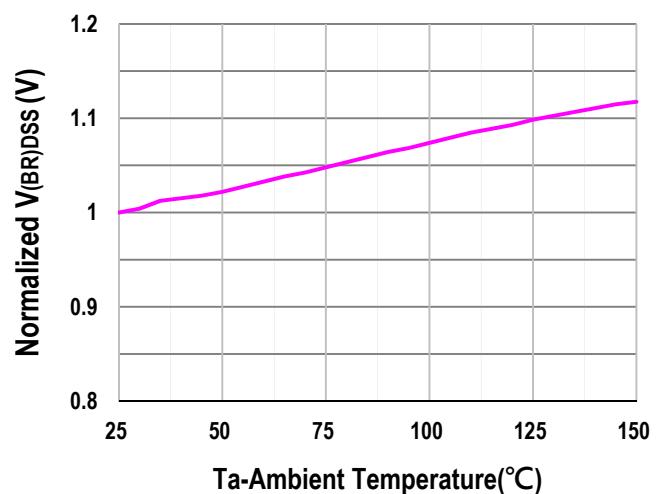
STATIC CHARACTERISTICS						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Gate Threshold Voltage	$V_{\text{GS(TH)}}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{DS}}=250\mu\text{A}$	2.7	3.0	3.3	V
Drain-Source On-State Resistance	$R_{\text{DS(ON)}}$	$V_{\text{GS}}=10\text{V}, I_{\text{DS}}=12\text{A}$	-	151	180	$\text{m}\Omega$
Gate Resistance	R_{G}	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V}, f=1\text{MHz}$	-	4.6	-	Ω
Forward Transconductance	g_{fs}	$V_{\text{DS}}=10\text{V}, I_{\text{DS}}=12\text{A}$	-	16.1	-	S

DYNAMIC CHARACTERISTICS						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Input Capacitance	C_{iss}	$V_{\text{DD}}=650\text{V}, V_{\text{DS}}=325\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	1754	-	pF
Output Capacitance	C_{oss}	$V_{\text{DD}}=650\text{V}, V_{\text{DS}}=325\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	20.7	-	pF
Reverse Transfer Capacitance	C_{rss}	$V_{\text{DD}}=650\text{V}, V_{\text{DS}}=325\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	4.9	-	pF
Effective output capacitance-energy	$C_{\text{o(er)}}$	$V_{\text{DD}}=400\text{V}, V_{\text{G}}=10\text{V}$, energy related Note 6	-	144	-	pF
Effective output capacitance-time	$C_{\text{o(tr)}}$	$V_{\text{DD}}=400\text{V}, V_{\text{G}}=10\text{V}$, time related Note 7	-	598	-	pF
Turn-On Delay Time	$T_{\text{d(on)}}$	$V_{\text{DS}}=400\text{V}, V_{\text{GS}}=10\text{V}, I_{\text{DS}}=10\text{A}, R_{\text{GEN}}=10\Omega$	-	15.3	-	nS
Rise Time	t_{r}	$V_{\text{DS}}=400\text{V}, V_{\text{GS}}=10\text{V}, I_{\text{DS}}=10\text{A}, R_{\text{GEN}}=10\Omega$	-	22.2	-	nS
Turn-Off Delay Time	$T_{\text{d(off)}}$	$V_{\text{DS}}=400\text{V}, V_{\text{GS}}=10\text{V}, I_{\text{DS}}=10\text{A}, R_{\text{GEN}}=10\Omega$	-	83	-	nS
Fall Time	t_{f}	$V_{\text{DS}}=400\text{V}, V_{\text{GS}}=10\text{V}, I_{\text{DS}}=10\text{A}, R_{\text{GEN}}=10\Omega$	-	31.6	-	nS

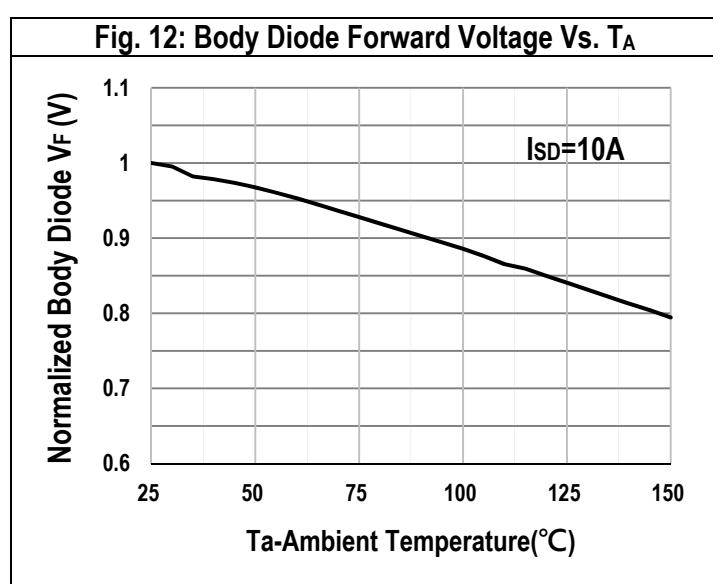
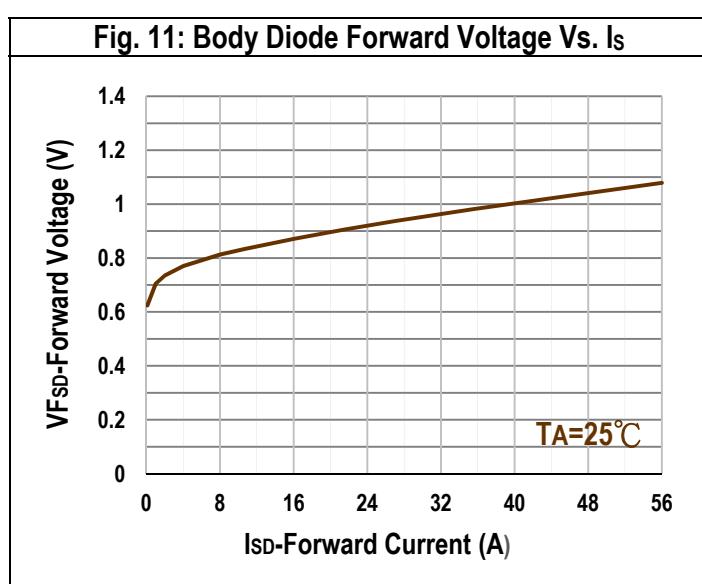
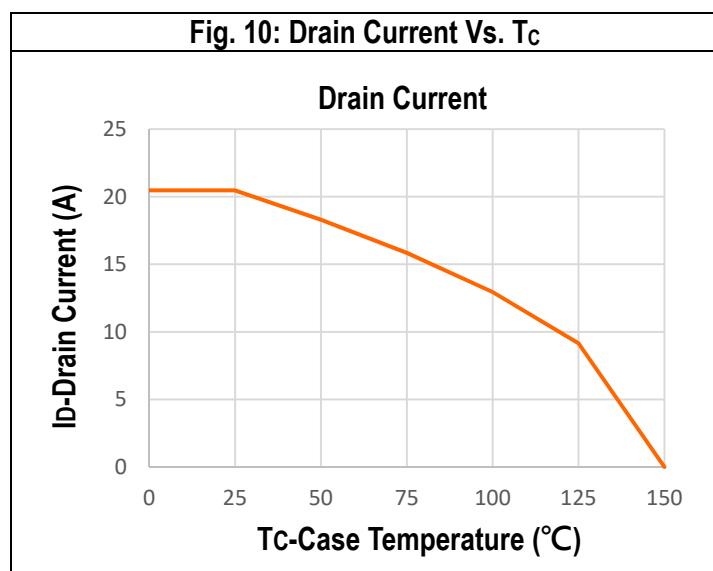
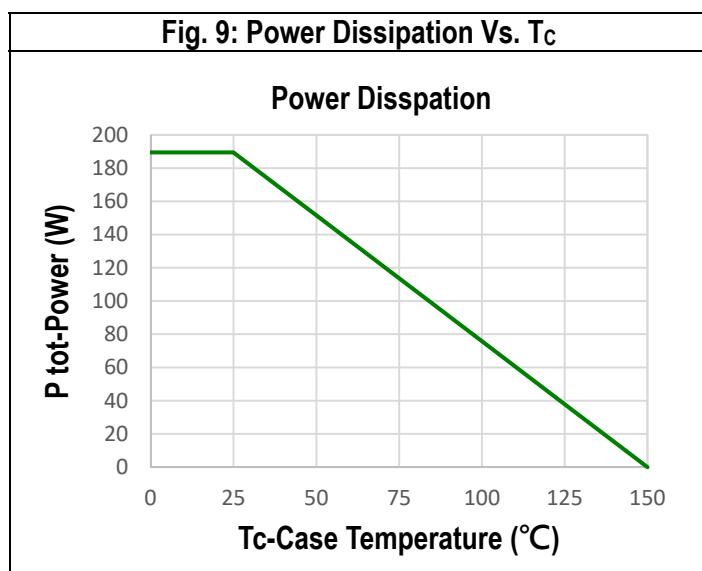
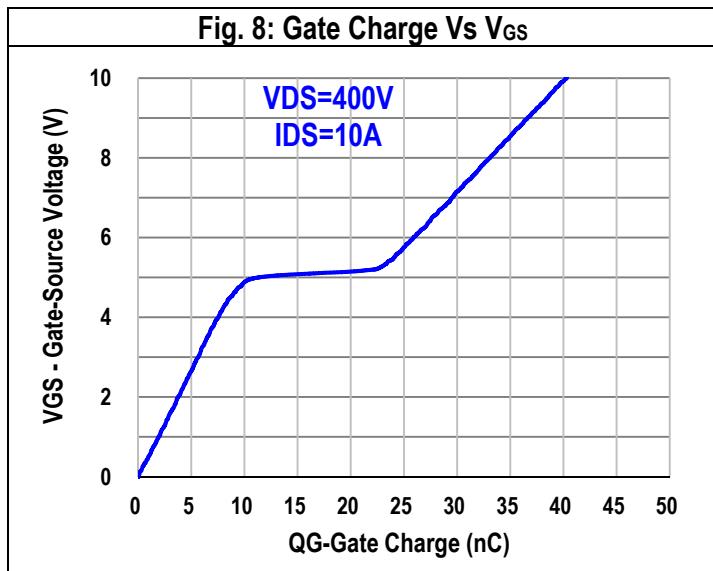
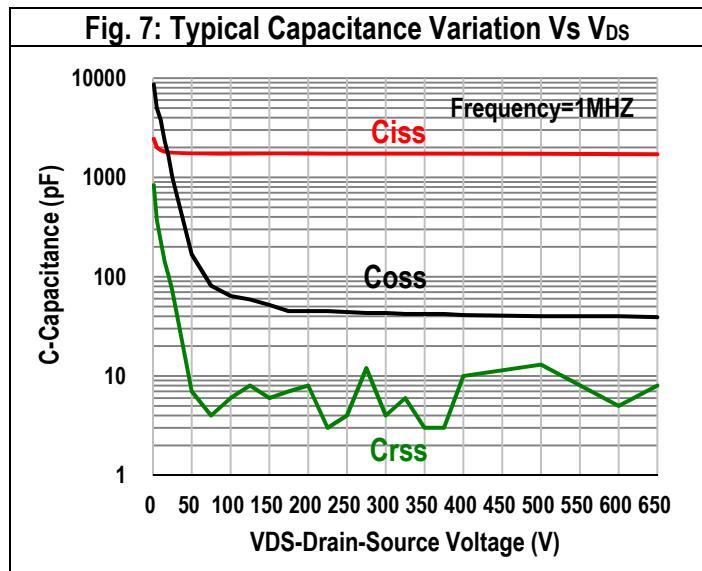
GATE CHARGE CHARACTERISTICS						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Gate charge total	$Q_{\text{g 10V}}$	$V_{\text{DD}}=400\text{V}, I_{\text{D}}=10\text{A}, V_{\text{GS}}=0 \text{ to } 10\text{V}$	-	40.2	-	nC
Gate to Source Gate Charge	Q_{gs}	$V_{\text{DD}}=400\text{V}, I_{\text{D}}=10\text{A}, V_{\text{GS}}=0 \text{ to } 10\text{V}$	-	9.7	-	nC
Gate to Drain Charge	Q_{gd}	$V_{\text{DD}}=400\text{V}, I_{\text{D}}=10\text{A}, V_{\text{GS}}=0 \text{ to } 10\text{V}$	-	13.3	-	nC
Gate plateau voltage	V_{plateau}	$V_{\text{DD}}=400\text{V}, I_{\text{D}}=10\text{A}, V_{\text{GS}}=0 \text{ to } 10\text{V}$	-	5.0	-	V

BODY DIODE CHARACTERISTICS AND MAXIMUM RATINGS						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Diode continuous forward current	I_{s}	$T_c=25^\circ\text{C}$	-	-	20.4	A
Diode pulsed forward current	I_{SM}	$T_c=25^\circ\text{C}$	-	-	70	A
Diode forward Voltage	V_{SD}	$T_c=25^\circ\text{C}, V_{\text{GS}}=0\text{V}, I_{\text{s}}=12\text{A}$	-	0.84	1.0	V
Diode reverse Recovery Time	t_{rr}	$V_{\text{DD}}=400\text{V}, I_{\text{SD}}=10\text{A}, T_c=25^\circ\text{C}, di/dt=50\text{A}/\mu\text{s}$	-	390	-	nS
Diode reverse Recovery Charge	Q_{rr}	$V_{\text{DD}}=400\text{V}, I_{\text{SD}}=10\text{A}, T_c=25^\circ\text{C}, di/dt=50\text{A}/\mu\text{s}$	-	4137	-	nC
Diode peak reverse recovery current	I_{rm}	$V_{\text{DD}}=400\text{V}, I_{\text{SD}}=10\text{A}, T_c=25^\circ\text{C}, di/dt=50\text{A}/\mu\text{s}$	-	22.3	-	A

4. Typical Operating Characteristics diagrams

Fig. 1: Output Characteristics

Fig. 2: Normalized $V_{(TH)GS}$ Voltage Vs. T_A

Fig. 3: Drain-Source On Resistance Vs V_{GS}

Fig. 4: Normalized $R_{DS(ON)}$ Resistance Vs. T_A

Fig. 5: Drain-Source On Resistance Vs I_D

Fig. 6: Normalized $BVDSS$ Voltage Vs TA


4. Typical Operating Characteristics diagrams



4. Typical Operating Characteristics diagrams

Fig. 13: Safe Operation Area

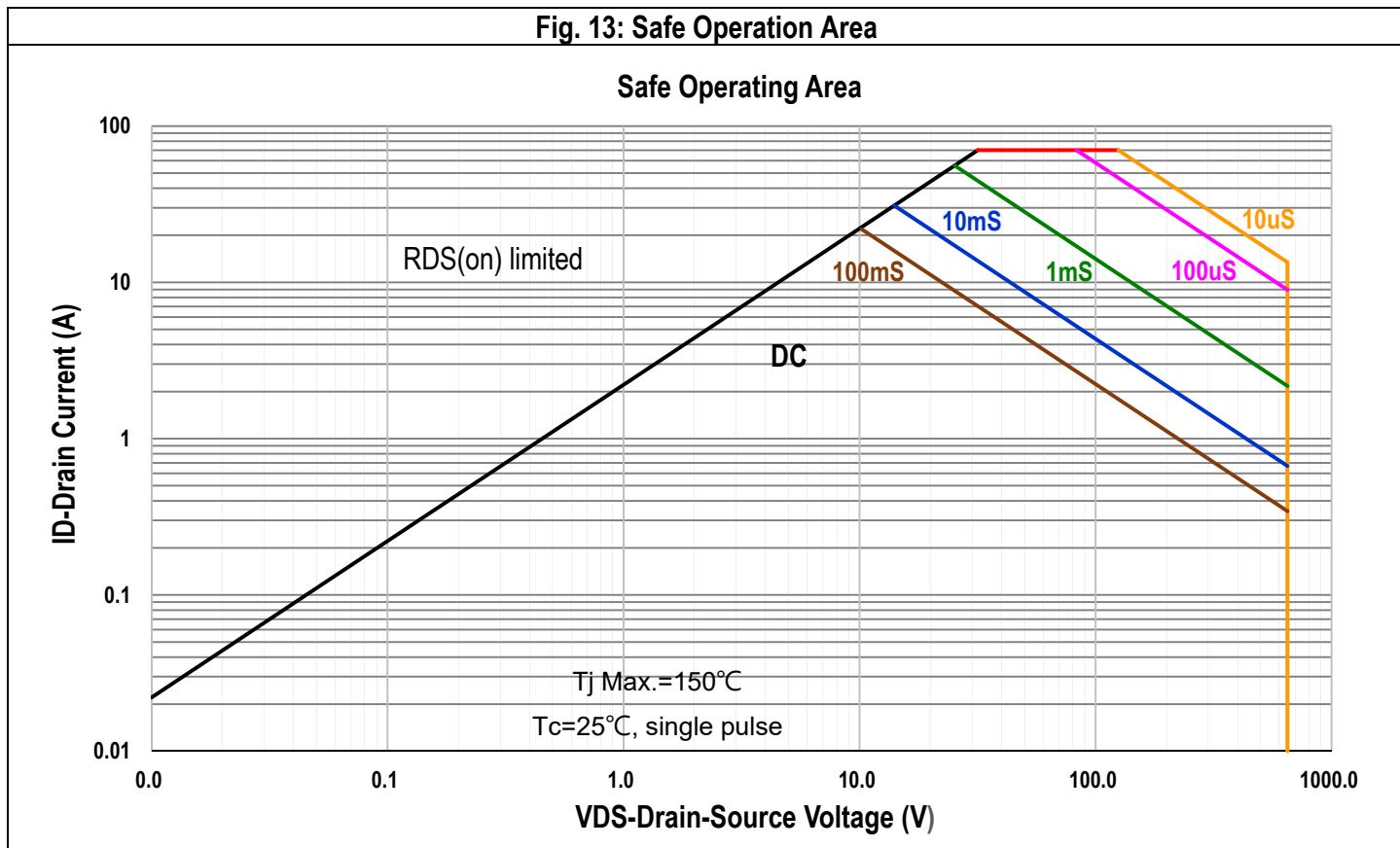
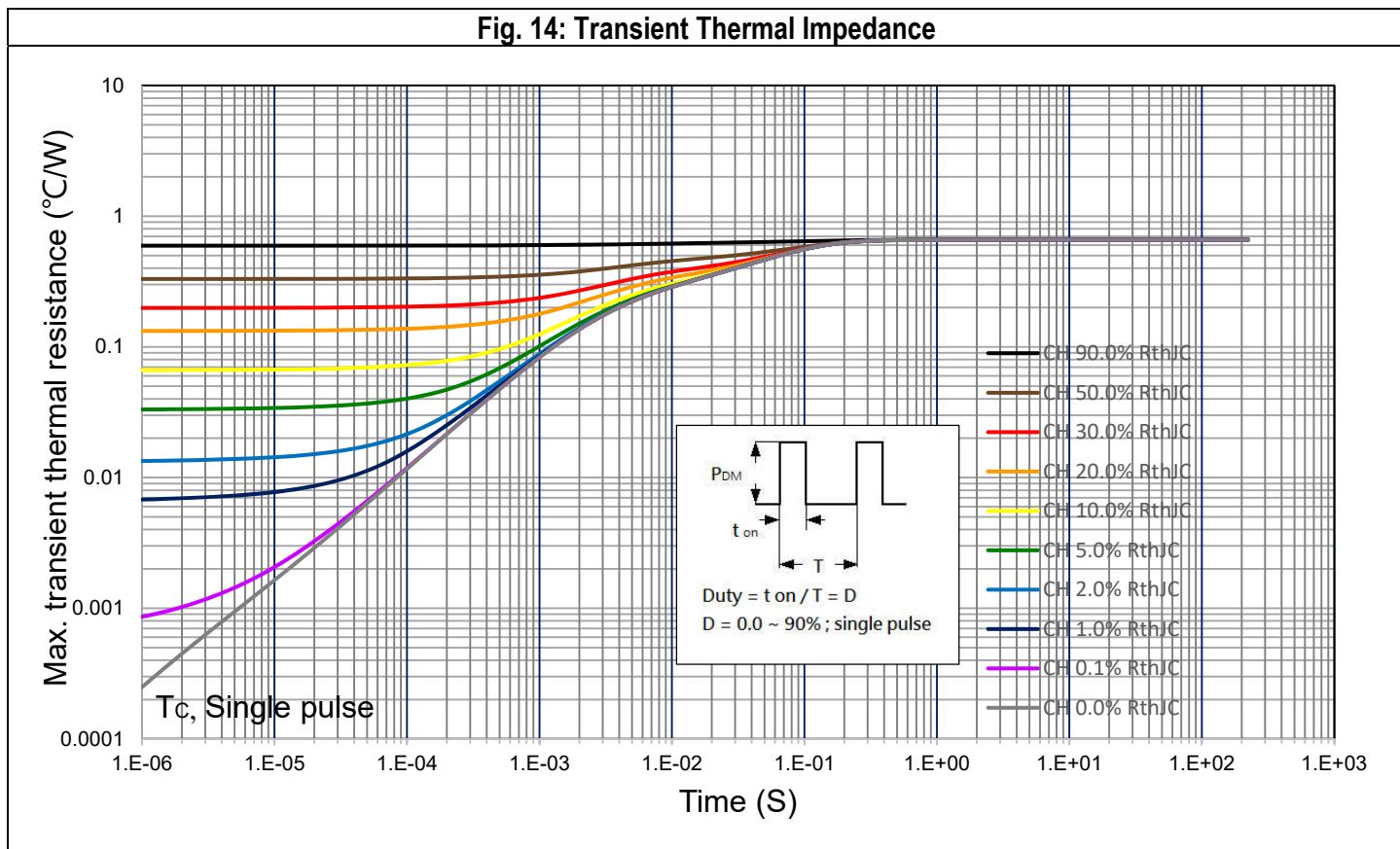


Fig. 14: Transient Thermal Impedance



5. Measurement Schematic

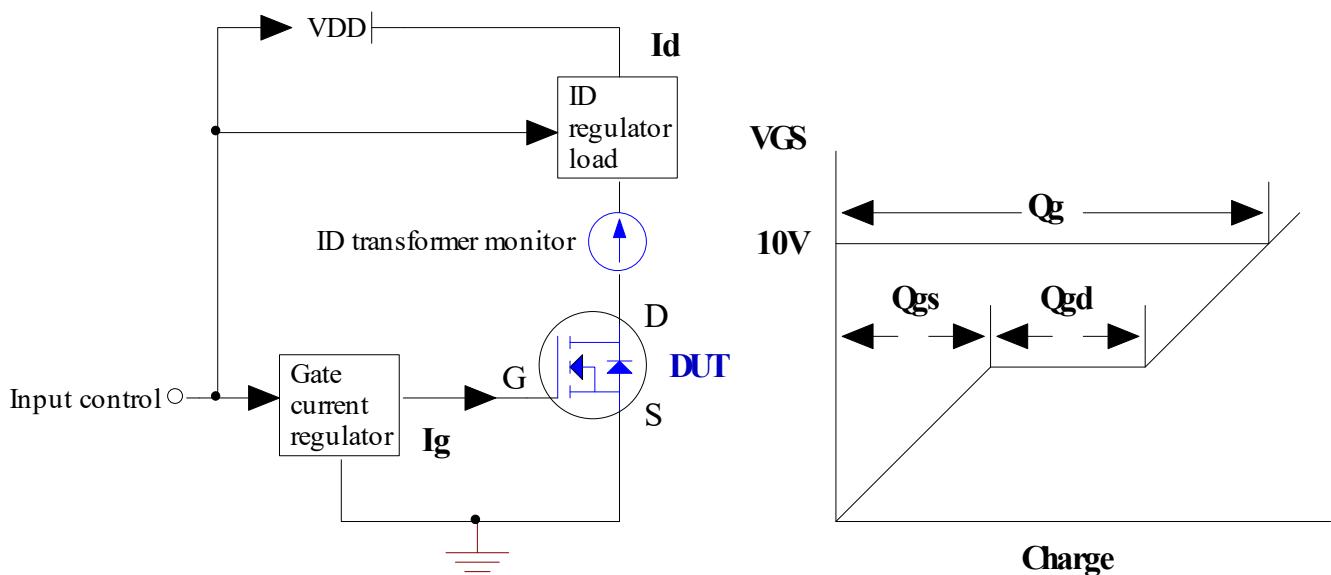


Diagram 5.1 Gate Charge Measurement Circuit and Waveforms

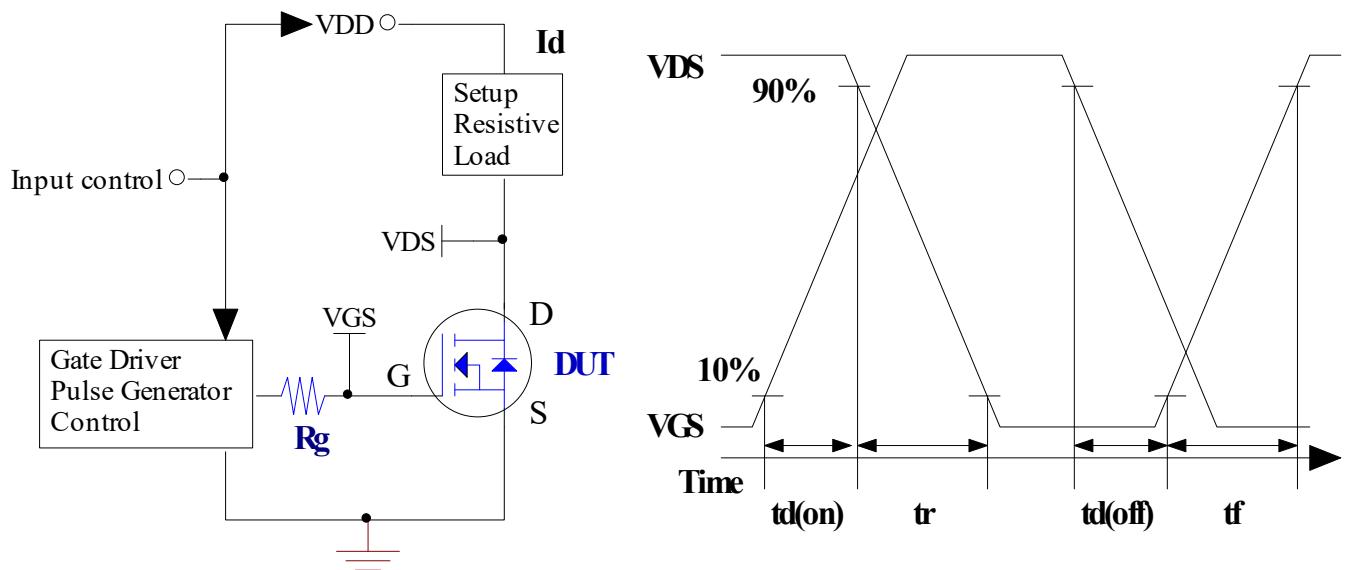


Diagram 5.2 Resistive Switching Measurement Circuit and Waveforms

5. Measurement Schematic

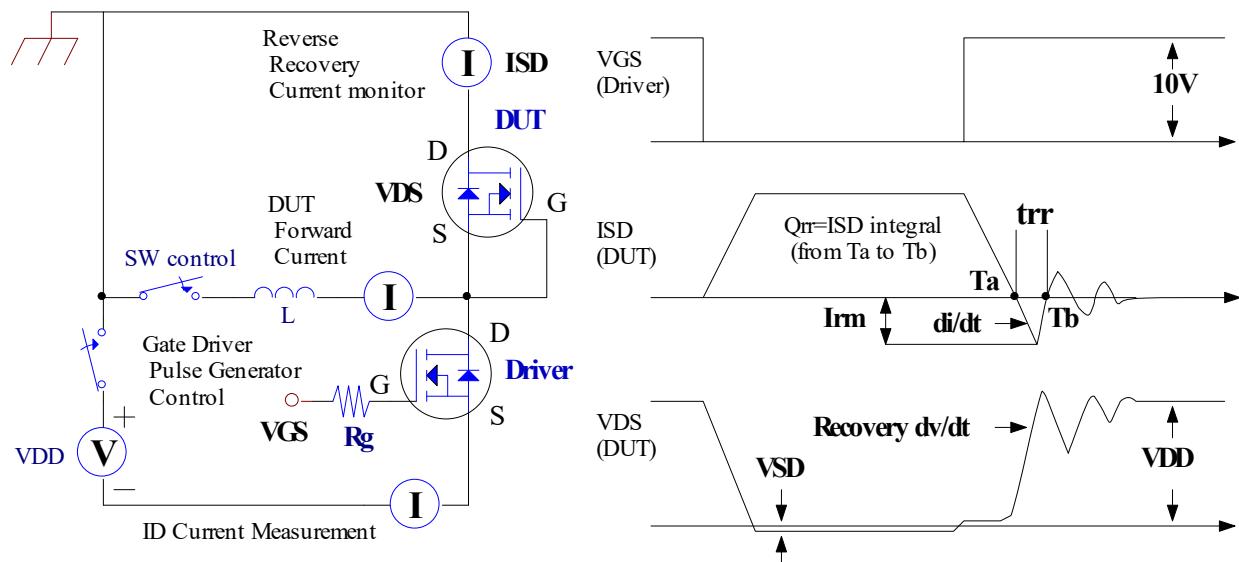


Diagram 5.3 Body Diode Recovery Characteristics Measurement Circuit and Waveforms

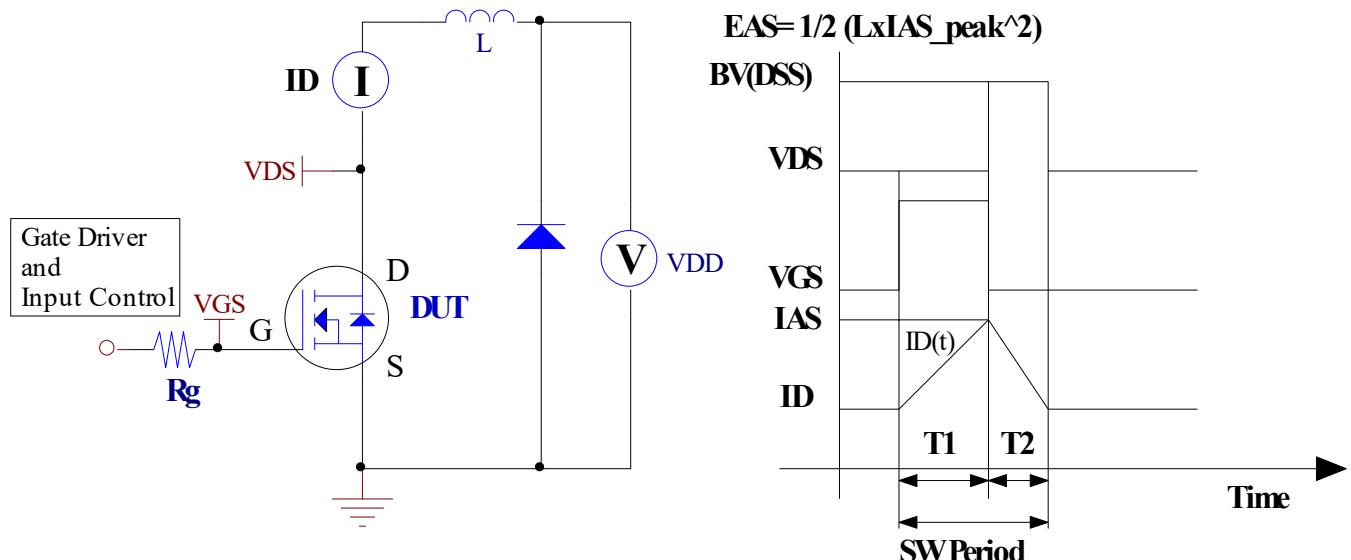
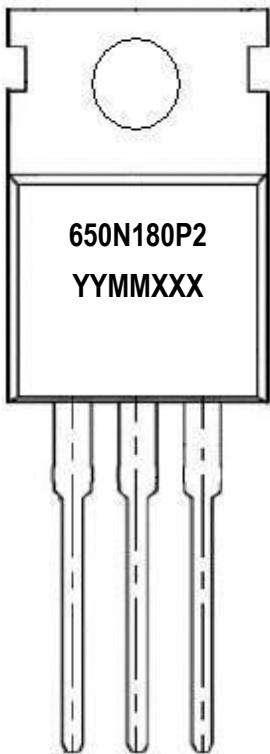


Diagram 5.4 Unclamped Inductive Switching Measurement Circuit and Waveforms

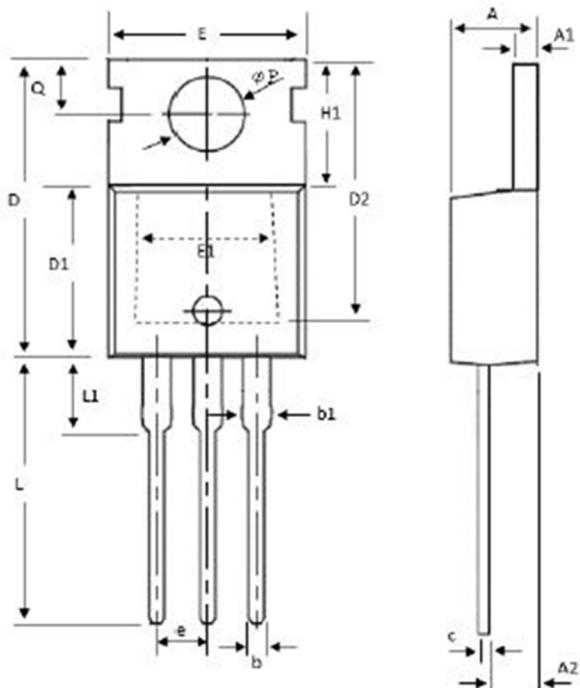
6. Marking Information

TO-220AB (P)	Marking Rule
Laser Marking  <p>650N180P2 YYMMXXX</p>	<p><u>Line 1</u> : Device 650N180P2</p> <p><u>Line 2</u> : Date Code YYMMXXX</p> <p>YY : Year Code MM : Month Code XXX : Serial Number</p>

7. Package of Dimension

Package type: TO-220AB

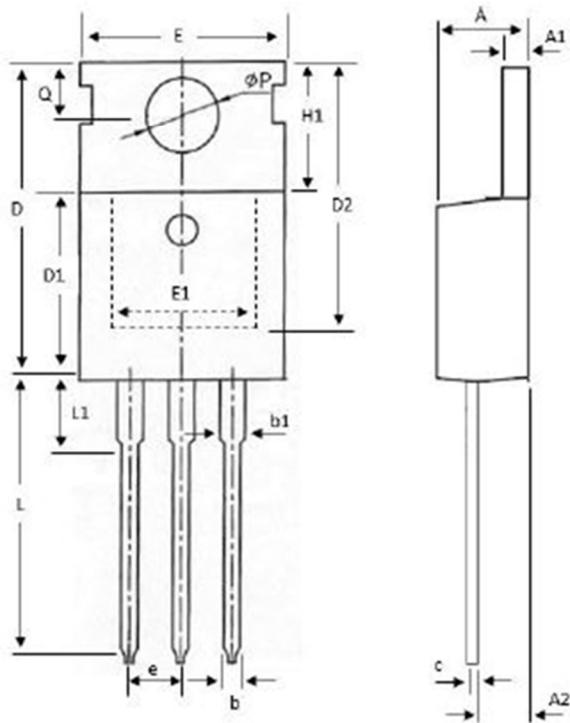
G-TYPE



Symbol	Min	Nor	Max
A	4.20	4.45	4.70
A1	1.15	1.28	1.40
A2	2.20	2.45	2.70
b	0.70	0.83	0.95
b1	1.15	1.45	1.75
c	0.40	0.50	0.60
D1	8.80	9.10	9.40
D2	11.75	-	-
E	9.70	10.03	10.36
E1	6.86	-	-
e	2.54 BSC		
H1	6.25	6.55	6.85
L	12.75	13.38	14.00
L1	-	-	4.00
P	3.40	3.70	4.00
Q	2.60	2.80	3.00

P-TYPE

H-TYPE



8. Appendix

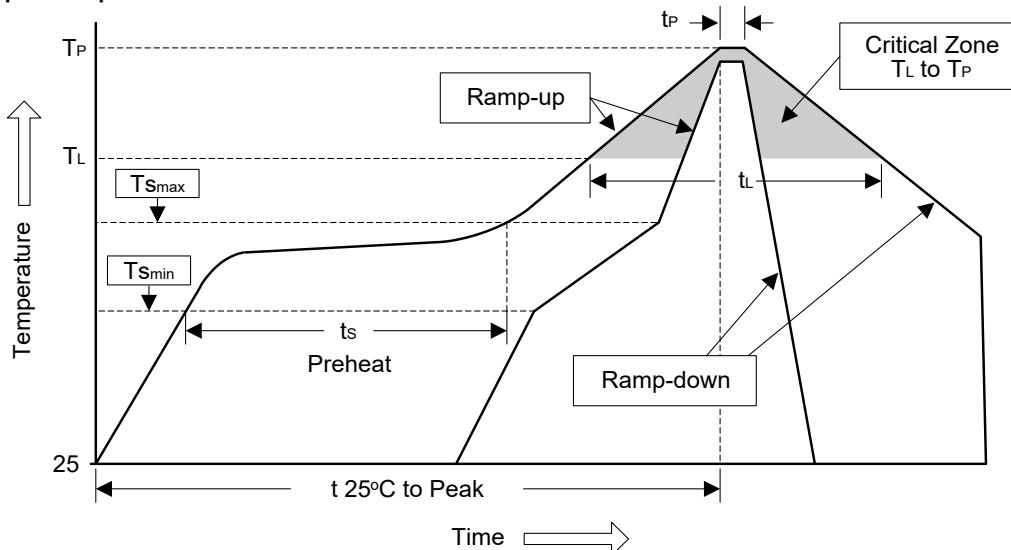
Appendix-A

Soldering Methods for Silicongear's Products (Just for SMD type of device)

1. Storage environment: Temperature=10°C to 35°C Humidity=65%±15%

2. Reflow soldering of surface-mount devices

Figure 1: Temperature profile



Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate (T_L to T_P)	<3°C/sec	<3°C/sec
Preheat		
- Temperature Min ($T_{S\min}$)	100°C	150°C
- Temperature Max ($T_{S\max}$)	150°C	200°C
- Time (min to max) (ts)	60 to 120 sec	60 to 180 sec
$T_{S\max}$ to T_L		
- Ramp-up Rate	<3°C/sec	<3°C/sec
Time maintained above:		
- Temperature (T_L)	183°C	217°C
- Time (t_L)	60 to 150 sec	60 to 150 sec
Peak Temperature (T_P)	240°C +0/-5°C	260°C +0/-5°C
Time within 5°C of actual Peak Temperature (t_P)	10 to 30 sec	20 to 40 sec
Ramp-down Rate	<6°C/sec	<6°C/sec
Time 25°C to Peak Temperature	<6 minutes	<8 minutes

3. Flow (wave) soldering (solder dipping)

Products	Peak Temperature	Dipping Time
Pb devices.	245°C ±5°C	5sec ±1sec
Pb-Free devices.	260°C +0/-5°C	5sec ±1sec

8. Appendix

Appendix-B

Important Notice

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